

**Search Notes****Application/Control No.**

10/531,343

**Examiner**

/Yonel Beaulieu/

**Applicant(s)/Patent under  
Reexamination**

MICH I ET AL.

**Art Unit**

3661

**SEARCHED**

Class	Subclass	Date	Examiner
701	200	4/17/2008	YB
	210		
	23		
	25-26		
	93		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST	4/17/2008	YB
	4/20/2008	YB